

**Notice of References Cited**

Application/Control No.

10/557,824

Applicant(s)/Patent Under  
Reexamination  
INOUE ET AL.

Examiner

Kwang Han

Art Unit

1795

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,063,911	06-2006	Nagai et al.	429/35
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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	K	US-			
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**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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**NON-PATENT DOCUMENTS**

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